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PRODUCT: ZEN098V130A24LS

DOCUMENT: SCD27645 REV LETTER: D REV DATE: JULY 26,2016 PAGE NO.: 1 OF 7

Specification Status: Preliminary



GENERAL DESCRIPTION

Littelfuse PolyZen devices are polymer enhanced, precision Zener diode microassemblies. They offer resettable protection against multi-Watt fault events without the need for multi-Watt heat sinks.

The Zener diode used for voltage clamping in a PolyZen micro-assembly is selected due to its relatively flat voltage versus his helps improve output voltage clamping

current response. This helps improve output voltage clamping, even when input voltage is high and diode current is large.

An advanced feature of the PolyZen micro-assembly is that the Zener diode is thermally coupled to a resistively non-linear, polymer PTC (positive temperature coefficient) layer. This PTC layer is fully integrated into the device, and is electrically in series between V_{IN} and the diode clamped V_{OUT} .

This advanced PTC layer responds to either extended diode heating or overcurrent events by transitioning from a low to high resistance state, also known as "tripping". A tripped PTC will limit current and generate voltage drop. It helps to protect both the Zener diode and the follow-on electronics and effectively increases the diode's power handling capability.

The polymer enhanced Zener diode helps protect sensitive portable electronics from damage caused by inductive voltage spikes, voltage transients, incorrect power supplies and reverse bias. These devices are particularly suitable for portable electronics and other low-power DC devices.

BENEFITS

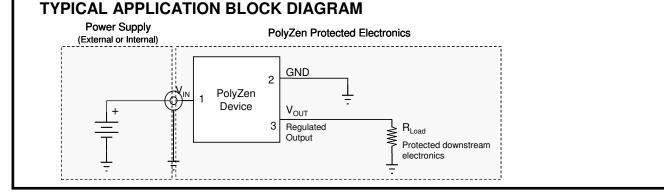
- Stable Zener diode helps shield downstream electronics from overvoltage and reverse bias
- Trip events shut out overvoltage and reverse bias sources
- Analog nature of trip events minimizes upstream inductive spikes
- Minimal power dissipation requiremen
- Single component placement

FEATURES

- Overvoltage transient suppression
- Stable Vz versus fault current
- Time delayed, overvoltage trip
- Time delayed, reverse bias trip
- Multi-Watt power handling capability
- Integrated device construction
- RoHS Compliant

TARGET APPLICATIONS

- DC power port protection in portable electronics
- DC power port protection for systems using barrel jacks for power input
- Internal overvoltage & transient suppression
- DC output voltage regulation



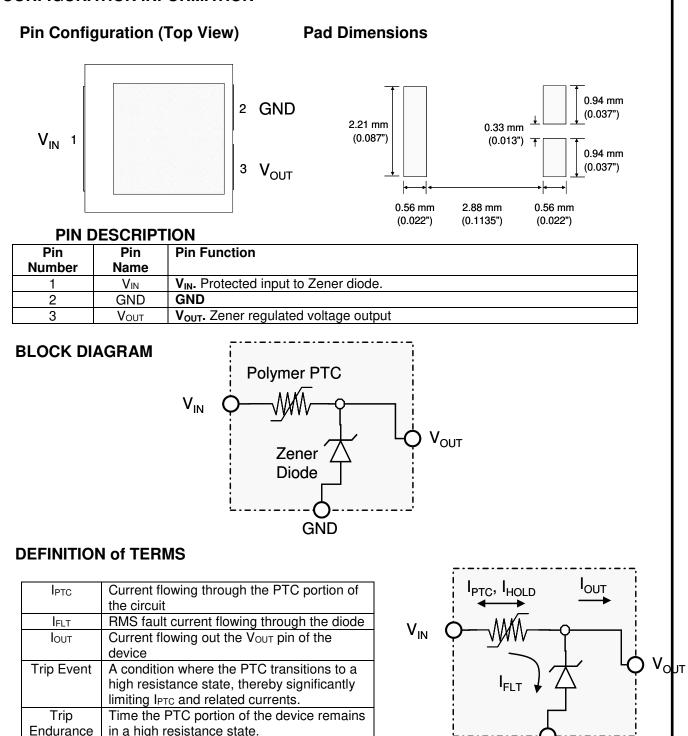
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CONFIGURATION INFORMATION



CNI



PolyZen Polymer Enhanced Zener Diode

Micro-Assemblies

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GENERAL SPECIFICATIONS

Operating Temperature Storage Temperature

-40º to +85ºC -40º to +85ºC

ELECTRICAL CHARACTERISTICS^{1-3, 11} (Typical unless otherwise specified)

Vz ⁴ (V)				I _{zt} ⁴ (A	Іно∟о ⁵ [@] 20⁰ С	Leakage Current		R Typ ⁶ (Ohms	R _{1Max} ⁷ (Ohms	V _{int} Max ⁸ (V)		I _{FLT} Max ⁹		Tripped Power Dissipation ¹⁰ Max Tes	
Mi n	Ту р	Max	x)	(A)	Test Voltag e	Max Curren t (mA)))	V _{INT} Ma x (V)	Test Curren t (A)	I _{FLT} Ma x (A)	Test Voltag e (V)	Valu e (W)	t Volt age (V)
9.6	9.8	10 0		0. 1	1.3	9.5	5	0.12	0.16	24V	ЗA	+3.5 -40	+24 -16V	1.0	24

Note 1: Electrical characteristics determined at 25°C unless otherwise specified.

Note 2:This device is intended for limited fault protection. Repeated trip events or extended trip endurance can degrade the device and may affect performance to specifications. Performance impact will depend on multiple factors including, but not limited to, voltage, trip current, trip duration, trip cycles, and circuit design. For details or ratings specific to your application contact, Littelfuse Circuit Protection Division directly.

Note 3:Specifications developed using 1.0 ounce 0.045" wide copper traces on dedicated FR4 test boards. Performance in your application may vary.

Note 4: I_{zt} is the current at which V_z is measured ($V_z = V_{OUT}$). Additional V_z values are available on request.

Note 5:I_{HOLD}: Maximum steady state I_{PTC} (current entering or exiting the V_{IN} pin of the device) that will not generate a trip even at the specified temperature. Specification assumes I_{FLT} (current flowing through the Zener diode) is sufficiently low so as to prevent the diode from acting as a heat source. Testing is conducted with an "open" Zener.

Note 6:R Typ: Resistance between V_{IN} and V_{OUT} pins during normal operation at room temperature.

Note 7:R_{1Max}:The maximum resistance between V_{IN} and V_{OUT} pins at room temperature, one hour after 1st trip or after reflow soldering.

Note 8:V_{INT} Max: V_{INT} Max relates to the voltage across the PPTC portion of the PolyZen device (V_{IN}-V_{OUT}). V_{INT} Max is defined as the voltage (V_{IN}-V_{OUT}) at which typical qualification devices (98% devices, 95% confidence) survived at least 100 trip cycles and 24 hours trip endurance at the specified voltage (V_{IN}-V_{OUT}) and current (I_{PTC}). V_{INT} Max testing is conducted using a "shorted" load (V_{OUT} = 0 V). V_{INT} Max is a survivability rating, not a performance rating.

Note 9:IFLT Max: IFLT Max relates to the steady state current flowing through the diode portion of the PolyZen device in a fault condition, prior to a trip event. IFLT Max is defined as the current at which typical qualification devices (12 parts per lot from 3 lots) survived 100 test cycles. RMS fault current above IFLT Max may permanently damage the diode portion o the PolyZen device. Testing is conducted with <u>NO</u> load connected to Vout, such that Iout = 0. "Test voltage" is defined as the voltage between VIN to GND and includes the PolyZen Diode drop. Specification is dependent on the direction of current flow through the diode. IFLT Max is a survivability rating, not a performance rating.

Note 10:The power dissipated by the device when in the "tripped" state, as measured on Littelfuse test boards (see note 3). Note 11:Specifications based on limited qualification data and subject to change.



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MECHANICAL DIMENSIONS

••	
	Length
	Width
	Height
	Length Diode
	Height Diode

		Min	Typical	Max
Length	1	3.85 mm	4 mm	4.15 mm
Length	L	(0.152")	(0.16")	(0.163")
Width	W	3.85 mm	4 mm	4.15 mm
WIGUI	**	(0.152")	(0.16")	(0.163")
Height	н	1.4mm	1.7 mm	2.0 mm
rieigni		(0.055")	(0.067")	(0.081")
Length Diode	Ld	_	3.0 mm	_
Length Diode	Lu		(0.118")	
Height Diode	Hd	_	1.0 mm	_
noight blode	T G		(0.039")	
Offset	01	_	0.6 mm	_
Onder	01		(0.024")	
Offset	O2	-	0.7 mm	-
01000	52		(0.028")	

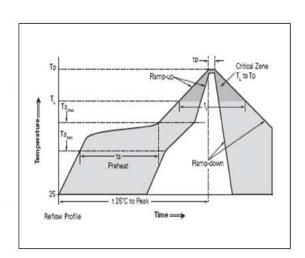
SOLDER REFLOW RECOMMENDATIONS:

Classification Reflow Profiles			
Profile Feature	Pb-Free Assembly		
Average Ramp-Up Rate (Tsmax to Tp)	3 °C/second max.		
Preheat			
• Temperature Min (Tsmin)	150 °C		
• Temperature Max (Tsmax)	200 °C		
• Time (tsmin to tsmax)	60-180 seconds		
Time maintained above:			
Temperature (TL)	217 °C		
• Time (tL)	60-150 seconds		
Peak/Classification Temperature (Tp)	260 °C		
Time within 5 °C of actual Peak			
Temperature (tp)	20-40 seconds		
Ramp-Down Rate	6 °C/second max.		
Time 25 °C to Peak Temperature	8 minutes max.		



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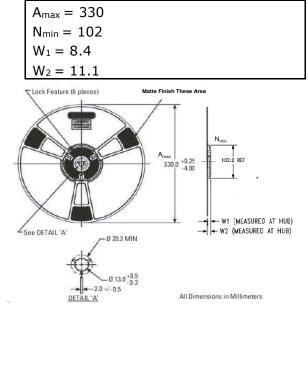
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PACKAGING

Packaging	Tape & Reel	Standard Box
ZENXXXVXXXAXXLS	3,000	15,000

Reel Dimensions for PolyZen Devices





PolyZen Polymer Enhanced Zener Diode

Micro-Assemblies

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